

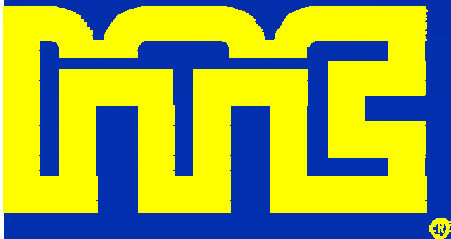
An Effort-Minimized Logic BIST Implementation Method

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Purpose

- Reduce system test and diagnosis cost
- Reduce the usage of expensive testers by:
 - Reducing tester I/O requirement
 - Reducing tester memory requirement
 - Reducing tester usage time
- Improve test quality by performing at-speed test
- Achieve >95% coverage with LBIST and top-up with ATPG

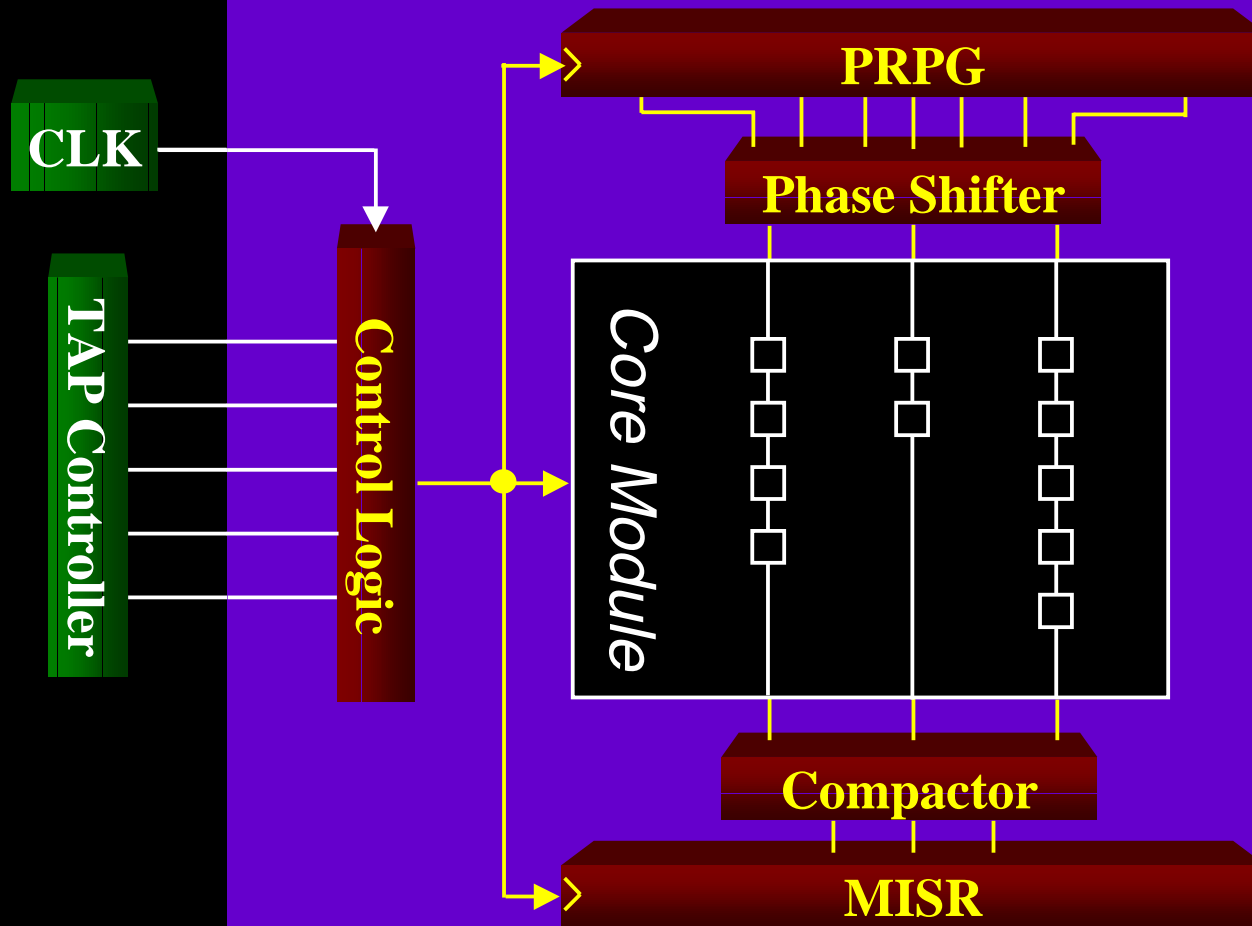
Outline

- LBIST general
- Problem specification
- Constrained LBIST insertion
- A design case

LBIST General – Architecture

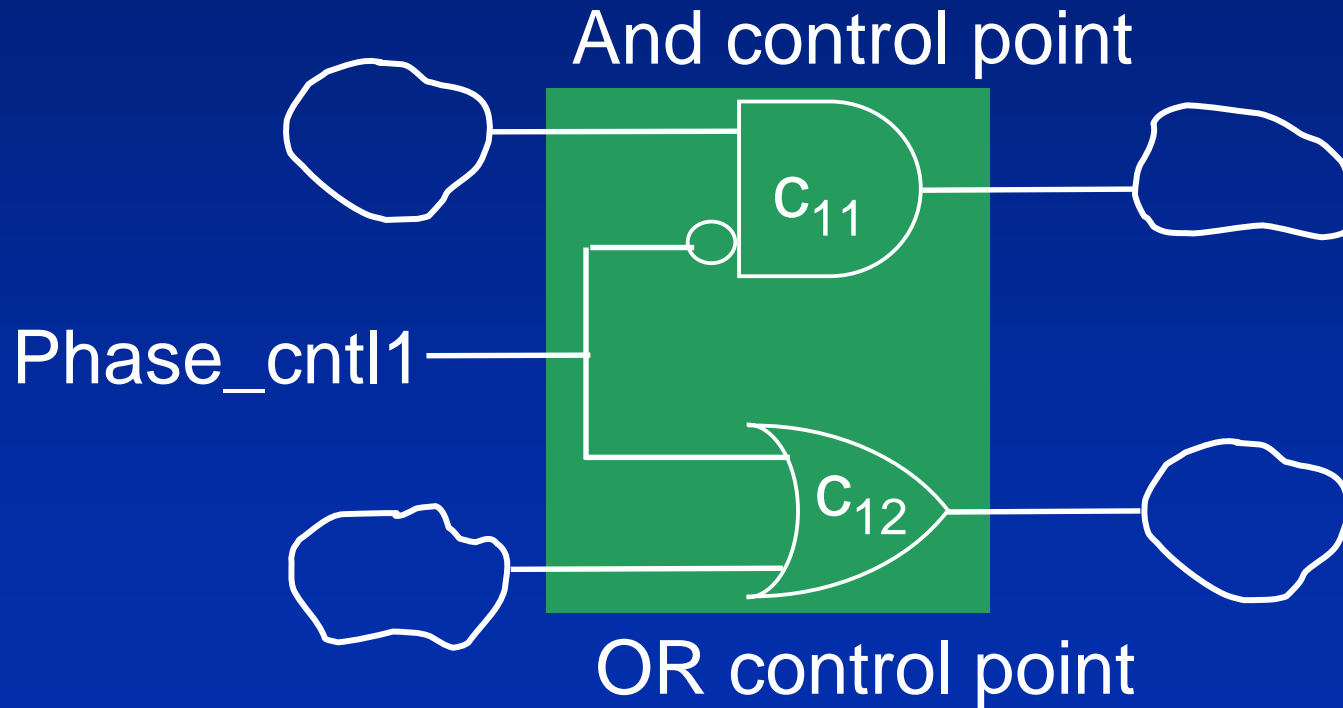
Top Module

LBISTed Core Module



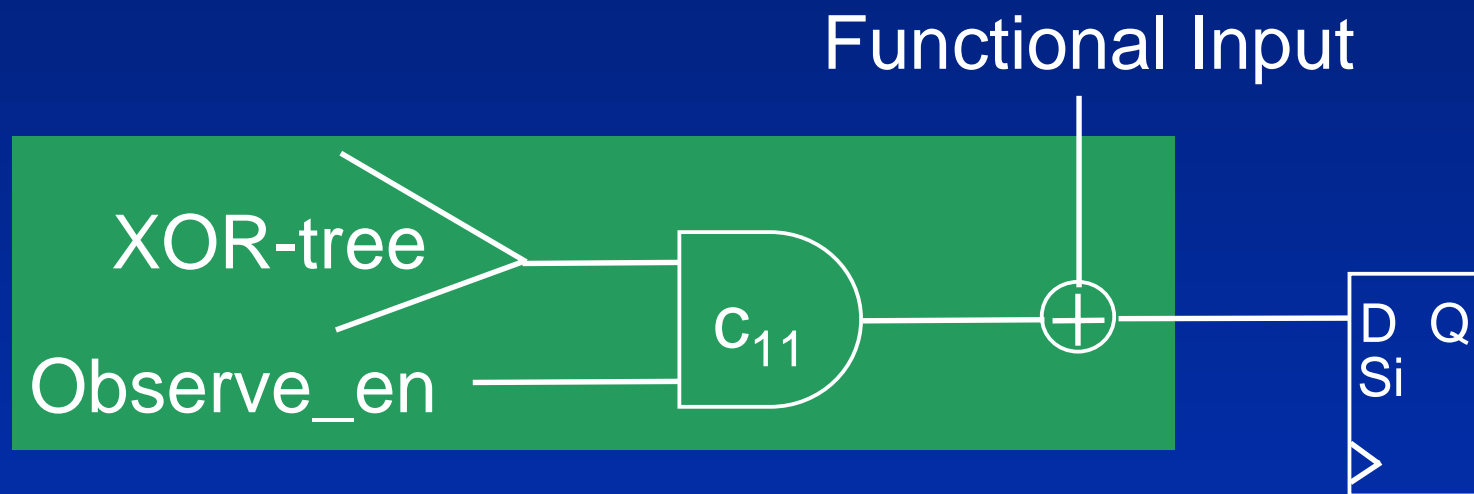
LBIST General – Control Points

- To increase controllability



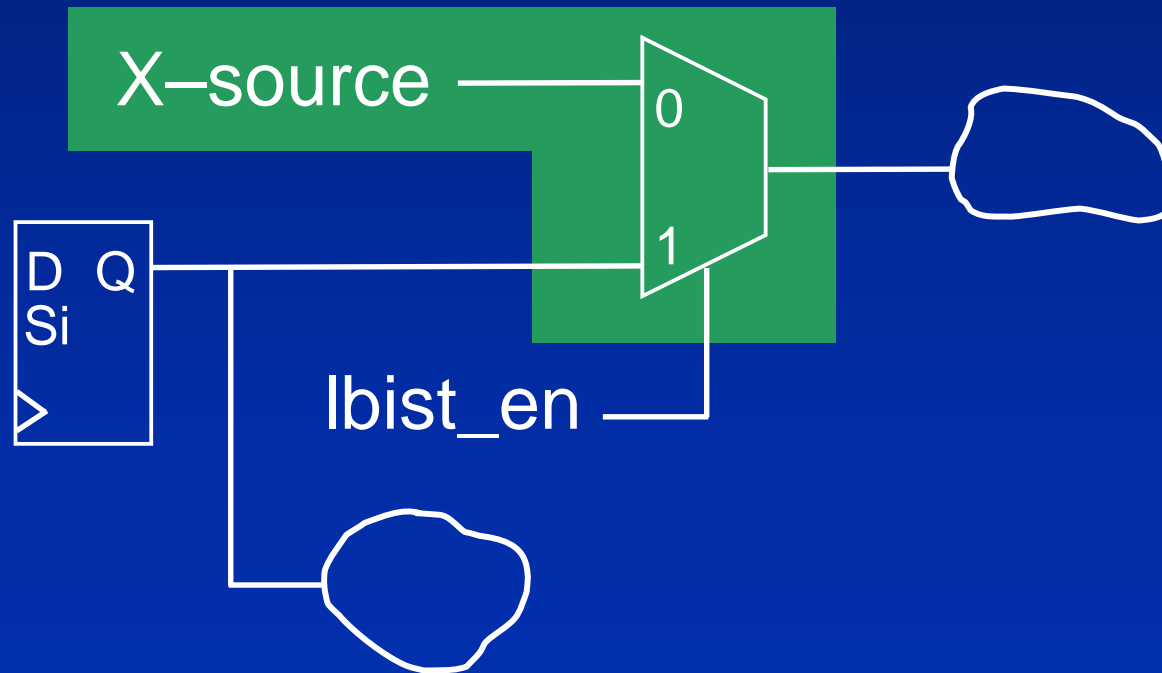
LBIST General – Observe Points

- To increase observability



LBIST General – X Boundings

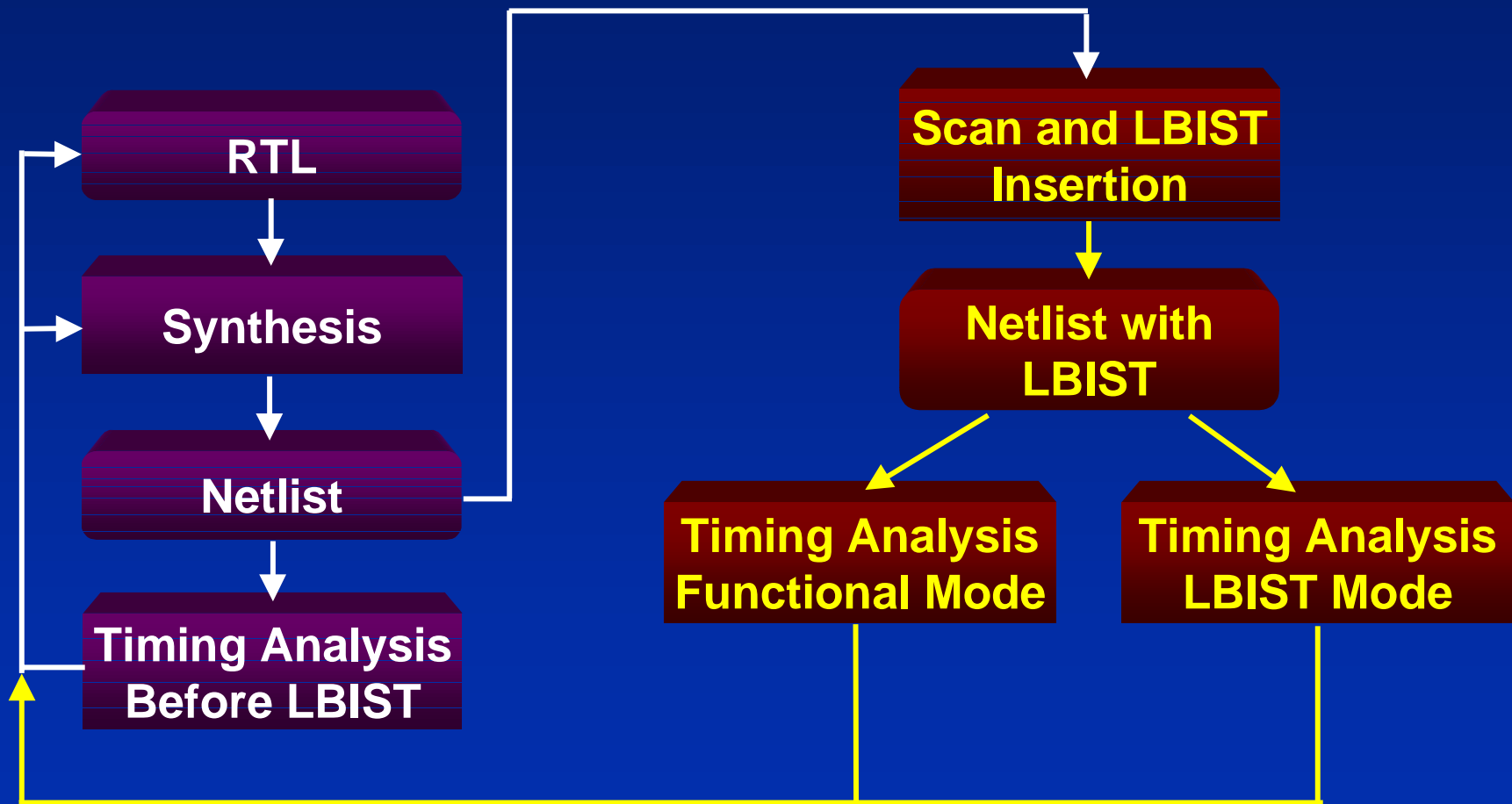
- X-bounding logic to prevent x-propagation to a MISR



LBIST General – X Boundings (cont)

- Types of x-sources:
 - Uncontrolled primary inputs
 - Floating nets
 - Non-scannable flip-flops
 - Black-boxed memory outputs
 - Buses with potential contention, etc.

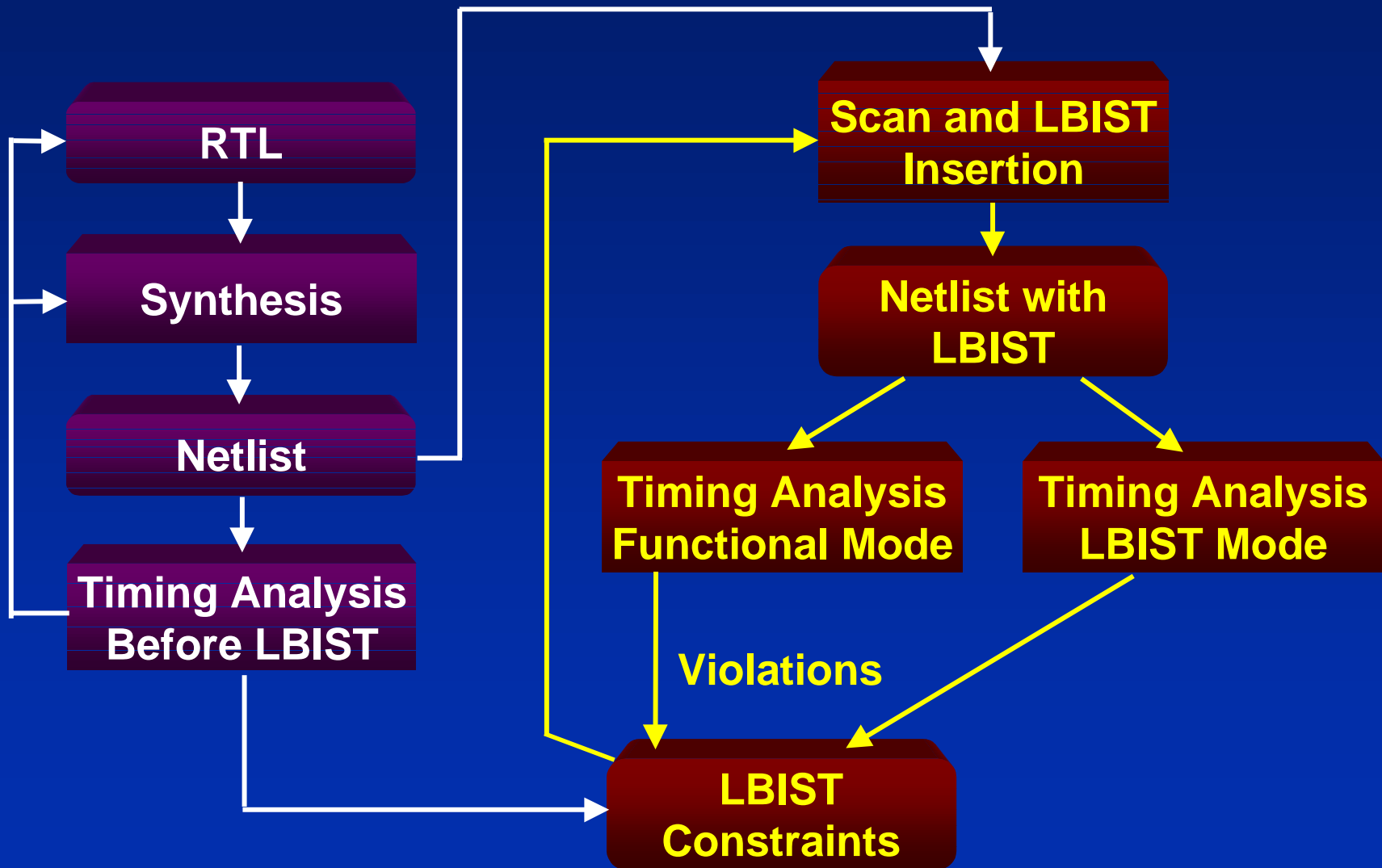
LBIST General – Design Flow



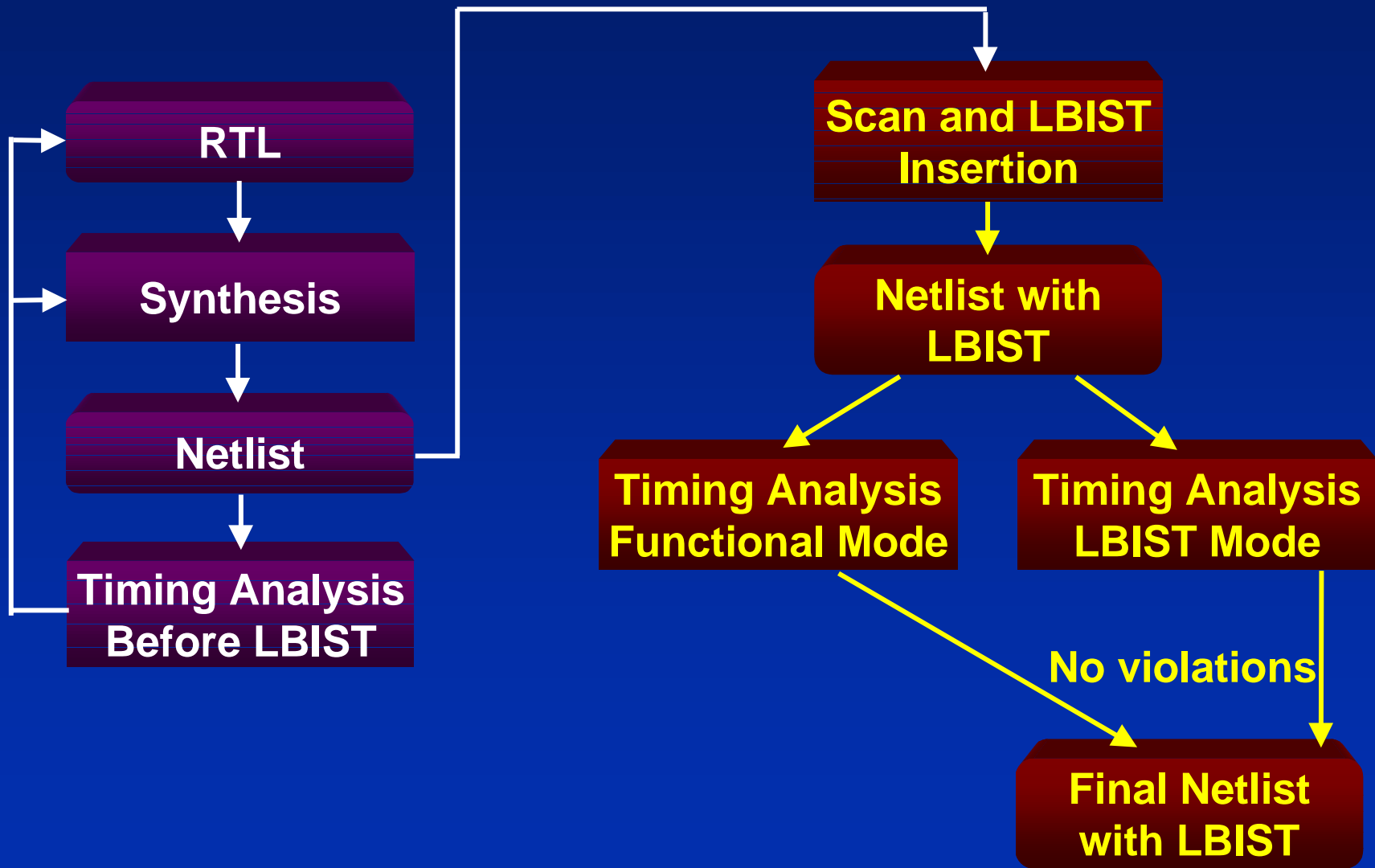
Problem Specification

- New timing violations in functional mode caused by
 - Control points
 - Observe points
 - X-boundings
- Extra timing violations in LBIST mode caused by
 - Multi-cycle paths
 - False-paths

Timing Constrained LBIST – Flow



Timing Constrained LBIST – Flow



Test Point Insertion

- TP_{ctrl} : a set of control points inserted
- TP_{obs} : a set of observe points inserted
- TP_{xbnd} : a set of x-boundings inserted

Timing Analysis

- P_{func} : a set of timing violation paths before LBIST
- P_{lbist} : a set of timing violation paths after LBIST in functional mode
- P_{false} : a set of timing violation paths after LBIST in LBIST mode

Timing Analysis (cont)

- $(P_{lbist} - P_{func})$: a set of timing violation paths in functional mode caused by LBIST
- $(P_{false} - P_{lbist})$: a set of timing violation paths in LBIST mode caused by multi-cycle paths or false paths

Timing Violations vs. Test Points

- Timing violation control points – \mathbf{TP}_{ctrl_vio} :
 $\{ TP \mid (TP \in \mathbf{TP}_{ctrl}) \wedge (\exists P \in (\mathbf{P}_{lbist} - \mathbf{P}_{func}) : TP \in P) \}$
- Timing violation observe points – \mathbf{TP}_{obs_vio} :
 $\{ TP \mid (TP \in \mathbf{TP}_{obs}) \wedge (\exists P \in (\mathbf{P}_{lbist} - \mathbf{P}_{func}) : TP \in P) \}$
- Timing violation x-boundings – \mathbf{TP}_{xbnd_vio} :
 $\{ TP \mid (TP \in \mathbf{TP}_{xbnd}) \wedge (\exists P \in (\mathbf{P}_{lbist} - \mathbf{P}_{func}) : TP \in P) \}$

Constrained LBIST Insertion

- New control points: $TP_{ctrl} - TP_{ctrl_vio}$
- New observe points: $TP_{obs} - TP_{obs_vio}$
- New x-boundings: $TP_{xbnd} - TP_{xbnd_vio}$
 - For each x-bounding in TP_{xbnd_vio} , disable the capture of “x” into scan FFs

Constrained LBIST Insertion (cont)

- ($P_{\text{false}} - P_{\text{lbist}}$) : timing violations in multi-cycle paths or false paths
 - Disable receiving FFs from capture

A Design Case

- LBIST and ATPG Comparison

	<u>Initial LBIST</u>	<u>ATPG</u>
Chains	200	10
Chain Length	321	6,852
Vectors	8,192	5,924
Coverage (%)	96.43	97.79
Test Cycles	2.6 M	40.6 M
Test Time (ms)	42	1,624

A Design Case (cont)

- Initial and Constrained LBIST Comparison

	<u>Initial LBIST</u>	<u>Constr. LBIST</u>
Control points	993	967
X-bound points	712	711
Observe points	1,000	1,000
Vectors	8,192	8,192
Coverage (%)	96.43	95.43

Conclusion

- Reduce manufacturing costs and ease system diagnosis by using LBIST
- Minimize LBIST design efforts by applying constrained LBIST technique
- Target 95% fault coverage with LBIST
- Prove the value of this technique on large industry designs